



FCC PART 15.247
EMI MEASUREMENT AND TEST REPORT

For
CCT R & D Limited

18F., CCT Telecom Building, 11 Wo Shing Street,
Fo Tan, Shatin, N.T.

FCC ID: NC8MD220H

This Report Concerns: <input checked="" type="checkbox"/> Original Report	Equipment Type: Digital Cordless Telephone System w/ Caller ID – Handset
	
Test Engineer: <u>Snell Leong</u>	
Report No.: <u>R0410184(H)</u>	
Report Date: <u>2004-11-09</u>	
	
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GENERAL INFORMATION

Product Description for Equipment Under Test (EUT)

The *CCT R & D Limited's*, FCC ID: NC8MD220H, or the "EUT" as referred to in this report is the handset part of a Digital Cordless Telephone System w/ Caller ID, which measures approximately 130mmL x 60mm W x 30mm H. The EUT is a DSS device, which operates at the frequency range of 2400.89 – 2479.40MHz, with the maximum conducted output power of 15.3dBm (33.88mW).

** The test data gathered are from a production sample, S/N: 4000009, provided by the manufacturer.*

Objective

This type approval report is prepared on behalf of *CCT R & D Limited* in accordance with Part 2, Subpart J, Part 15, Subparts A, B, C.

Related Submittal(s)/Grant(s)

No Related Submittals

Test Methodology

All measurements contained in this report were conducted with ANSI C63.4-2001& TIA/EIA-603.

Test Facility

The Open Area Test site used by BACL Corp. to collect radiated and conducted emission measurement data is located in the back parking lot of the building at 230 Commercial Street, Sunnyvale, California, USA.

Test site at BACL Corp. has been fully described in reports submitted to the Federal Communication Commission (FCC) and Voluntary Control Council for Interference (VCCI). The details of these reports has been found to be in compliance with the requirements of Section 2.948 of the FCC Rules on February 11 and December 10, 1997 and Article 8 of the VCCI regulations on December 25, 1997. The facility also complies with the test methods and procedures set forth in ANSI C63.4-2001& TIA/EIA-603.

The Federal Communications Commission and Voluntary Control Council for Interference has the reports on file and is listed under FCC file 31040/SIT 1300F2 and VCCI Registration No.: C-1298 and R-1234. The test site has been approved by the FCC and VCCI for public use and is listed in the FCC Public Access Link (PAL) database.

Additionally, BACL is a National Institute of Standards and Technology (NIST) accredited laboratory, under the National Voluntary Laboratory Accredited Program (Lab Code 200167-0). The scope of the accreditation covers the FCC Method - 47 CFR Part 15 - Digital Devices, CISPR 22:2002, Electromagnetic Interference - Limits and Methods of Measurement of Information Technology Equipment test methods.

SYSTEM TEST CONFIGURATION

Justification

The EUT was configured for testing according to ANSI C63.4-2001.

The EUT was tested in the normal (native) operating mode to represent *worst*-case results during the final qualification test.

EUT Exercise Software

The EUT exercise program used during radiated and conducted testing was designed to exercise the system components.

Once loaded, set the Tx channel to low, mid and high for testing.

Special Accessories

As shown in following test block diagram, all interface cables used for compliance testing are shielded.

Schematics / Block Diagram

Please refer to Appendix A.

Equipment Modifications

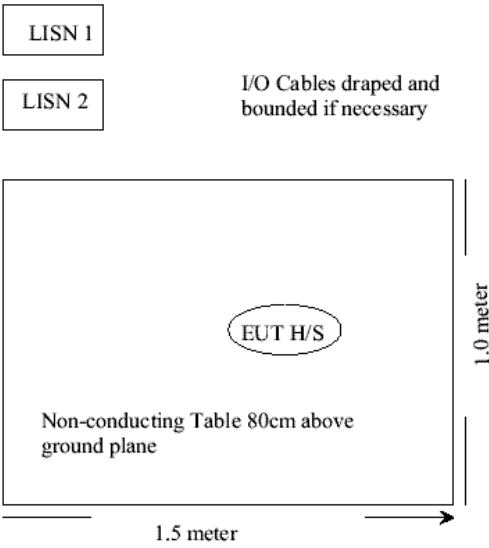
No modifications were made to the EUT.

Configuration of Test System



Handset

Test Setup Block Diagram



SUMMARY OF TEST RESULTS FOR FCC PART 15

FCC RULES	DESCRIPTION OF TEST	RESULT
§15.203	Antenna Requirement	Compliant
§ 15.205	Restricted Bands	N/A
§15.209	Radiated Emission	Within Measurement Uncertainty
§15.247 (a) (1)	Hopping Channel Separation	Compliant
§15.247 (a) (1)	Channel Bandwidth	Compliant
§15.247 (a) (1) (iii)	Number of Hopping Frequencies Used	Compliant
§15.247 (a) (1) (iii)	Dwell Time of Each Frequency within a 10 Second Period of time (0.4 x Number of Channel)	Compliant
§15.247 (b) (1)	Maximum Peak Output Power	Compliant
§ 15.247 (b)(4) § 2.1093	RF Safety Requirements	Compliant
§ 15.247 (c)	100 kHz Bandwidth of Frequency Band Edge	Compliant
	Spurious Emission at Antenna Port	Compliant

ANTENNA REQUIREMENT

According to § 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device.

And according to § 15.247 (1), if transmitting antennas of directional gain greater than 6 dBi are used the power shall be reduced by the amount in dB that the directional gain of the antenna exceeds 6 dBi.

The gain of antenna used for transmitting is 0 dBi by default, and the antenna connector is designed with permanent attachment and no consideration of replacement. Please see EUT photo for details.

§15.205 & §15.209 - RADIATED EMISSION

Measurement Uncertainty

All measurements involve certain levels of uncertainties, especially in field of EMC. The factors contributing to uncertainties are spectrum analyzer, cable loss, antenna factor calibration, antenna directivity, antenna factor variation with height, antenna phase center variation, antenna factor frequency interpolation, measurement distance variation, site imperfections, mismatch (average), and system repeatability.

Based on NIS 81, The Treatment of Uncertainty in EMC Measurements, the best estimate of the uncertainty of a radiation emissions measurement at BACL is ± 4.0 dB.

Test Setup

The radiated emission tests were performed in the open area 3-meter test site, using the setup in accordance with ANSI C63.4-2001. The specification used was the FCC 15 Subpart C limits.

The spacing between the peripherals was 10 centimeters.

External I/O cables were draped along the edge of the test table and bundle when necessary.

Spectrum Analyzer Setup

According to FCC Rules, 47 CFR §15.33 (a) (1), the system was tested to 25GHz.

During the radiated emission test, the spectrum analyzer was set with the following configurations:

<i>Frequency Range</i>	<i>RBW</i>	<i>Video B/W</i>
Below 30MHz	10kHz	10kHz
30 – 1000MHz	100kHz	100kHz
Above 1000MHz	1MHz	1MHz

Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Cal. Date
HP	Amplifier, Pre, microwave	8449B	3147A00400	2004-06-14
HP	Amplifier, Pre	8447E	1937A01057	2004-08-04
Agilent	Analyzer, Spectrum	8564E	3943A01781	2004-10-04
Agilent	Analyzer, Spectrum	E4448A	1030645	2004-10-04
ETS	Antenna, Biconical	3110B	9603-2315	2004-01-11
A. H. Systems	Antenna, Horn, DRG	SAS-200/571	2455-261	2004-08-01
EMCO	Antenna, logperiodic	3146	2101	2003-11-08

* **Statement of Traceability: BACL Corp.** attests that all calibrations have been performed per the NVLAP requirements, traceable to the NIST.

Environmental Conditions

Temperature:	18° C
Relative Humidity:	43%
ATM Pressure:	1018 mbar

**The testing was performed by Snell Leong on 2004-10-27.*

Test Procedure

For the radiated emissions test, both the laptop and all peripheral power cords were connected to the AC floor outlet since the power supply used in the laptop did not provide an accessory power outlet.

Maximizing procedure was performed on the six (6) highest emissions to ensure EUT compliance is with all installation combinations.

All data was recorded in the peak detection mode. Quasi-peak readings was performed only when an emission was found to be marginal (within -4 dB of specification limits), and are distinguished with a "Qp" in the data table.

Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and Cable Factor, and subtracting the Amplifier Gain from the Amplitude reading. The basic equation is as follows:

$$\text{Corr. Ampl.} = \text{Indicated Reading} + \text{Antenna Factor} + \text{Cable Factor} - \text{Amplifier Gain}$$

The "**Margin**" column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of -7dB means the emission is 7dB below the maximum limit for Class B. The equation for margin calculation is as follows:

$$\text{Margin} = \text{Corr. Ampl.} - \text{Class B Limit}$$

Summary of Test Results

According to the recorded data in following table, the EUT measured -0.3dB margin, within the measurement uncertainty of $\pm 4.0\text{dB}$, and had the worst margin of:

-4.9 dB at **4801.50 MHz** in the **Vertical** polarization, Low Channel, 3 meters

-2.2 dB at **4880.316 MHz** in the **Horizontal** polarization, Middle Channel, 3 meters

-6.1 dB at **4958.80 MHz** in the **Vertical** polarization, High Channel, 3 meters

-0.3 dB at **809.73 MHz** in the **Vertical** polarization, Unintentional Emission, 3 meters

3 Meters Radiated Emission Test Data

Indicated			Antenna	Antenna		Correction Factor			FCC 15.247		
Frequency MHz	Ampl. dBμV/m	Direction Degree	Height Meter	Polar H/V	Antenna dBm	Cable Loss dBm	Amp. dB	Corr. Ampl. dBμV/m	Limit dBμV/m	Margin dB	Comments
Low Channel											
2400.8900	117.5	350	2.0	v	28.1	0.9	35.8	110.7			Fund/Peak
2400.8900	116.0	180	3.0	h	28.1	0.9	35.8	109.2			Fund/Peak
4801.50	58.33	120	1.5	v	32.5	3.1	34.8	49.1	54	-4.9	Ave
4801.50	65.00	120	1.5	v	32.5	3.1	34.8	55.8	74	-18.2	Peak
4801.50	62.92	0	3.0	h	32.5	3.1	34.8	53.7	74	-20.3	Peak
2530.6700	65.2	120	1.5	v	29.0	2.4	35.5	51.1	74	-22.9	Peak
2530.6700	63.3	200	3.1	h	29.0	2.4	35.5	49.2	74	-24.8	Peak
2386.7000	64.0	120	3.0	v	28.1	2.0	35.8	48.3	74	-25.8	Peak
2386.7000	63.4	45	2.0	h	28.1	2.0	35.8	47.7	74	-26.3	Peak
Middle Channel											
2440.1580	115.2	45	2.0	v	28.1	0.9	35.8	108.4			Fund/Peak
2440.1580	111.0	45	2.2	h	28.1	0.9	35.8	104.2			Fund/Peak
4880.3160	61.1	0	1.5	h	32.5	3.1	34.8	51.8	54	-2.2	Ave
4880.3160	57.9	180	1.2	v	32.5	3.1	34.8	48.7	54	-5.3	Ave
2569.38	62.74	180	1.1	h	29.0	2.4	35.5	48.6	54	-5.4	Ave
4880.3160	69.7	0	1.5	h	32.5	3.1	34.8	60.4	74	-13.6	Peak
2569.38	68.44	180	1.1	h	29.0	2.4	35.5	54.3	74	-19.7	Peak
4880.3160	63.2	180	1.2	v	32.5	3.1	34.8	54.0	74	-20.0	Peak
2569.38	66.84	120	1.5	v	29.0	2.4	35.5	52.7	74	-21.3	Peak
2310.4000	67.7	180	1.5	h	28.1	2.0	35.8	51.9	74	-22.1	Peak
2310.4000	64.6	100	2.0	v	28.1	2.0	35.8	48.9	74	-25.1	Peak
High Channel											
2479.4000	113.7	180	1.8	v	28.1	0.9	35.8	106.9			Fund/Peak
2479.4000	109.3	0	1.8	h	28.1	0.9	35.8	102.5			Fund/Peak
4958.8000	57.1	90	2.3	v	32.5	3.1	34.8	47.9	54	-6.1	Ave
4958.8000	54.9	0	1.5	h	32.5	3.1	34.8	45.6	54	-8.4	Ave
4958.8000	69.7	90	2.3	v	32.5	3.1	34.8	60.5	74	-13.5	Peak
4958.8000	66.6	0	1.5	h	32.5	3.1	34.8	57.3	74	-16.7	Peak
2492.9700	69.5	0	1.5	h	28.1	2.0	35.8	53.8	74	-20.2	Peak
2492.9700	64.4	0	2.5	v	28.1	2.0	35.8	48.7	74	-25.3	Peak

Note:

FUND: Fundamental

AVG: Average

Unintentional Emission

Indicated			Antenna	Antenna		Correction Factor			FCC 15.247	
Frequency	Ampl.	Direction	Height	Polar	Antenna	Cable Loss	Amp.	Corr. Ampl.	Limit	Margin
MHz	dB μ V/m	Degree	Meter	H/V	dB/m	dBm	dB	dB μ V/m	dB μ V/m	dB
809.73	58.50	350	3.0	V	22.3	3.6	28.7	45.7	46	-0.3Peak
294.97	47.90	345	1.7	H	13.7	2.3	27.8	36.1	46	-9.9Peak
275.03	54.42	350	2.6	V	13.3	2.2	27.9	32.0	46	-14.0Peak

§15.247 (a) (1) - HOPPING CHANNEL SEPARATION

Standard Applicable

According to §15.247(a)(1), frequency hopping system shall have, hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. The system shall hop to channel frequencies that are selected at the system hopping rate from a pseudorandomly ordered list of hopping frequencies.

Measurement Procedure

1. Check the calibration of the measuring instrument (SA) using either an internal calibrator or a known signal from an external generator.
2. Position the EUT on a bench without connection to measurement instrument Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range.
3. By using the Max-Hold function record the separation of two adjacent channels.
4. Measure the frequency difference of these two adjacent channels by SA MARK function, and then plot the result on SA screen.
5. Repeat above procedures until all frequencies measured were complete.

Test Equipment

Manufacturer	Model No.	Description	Calibration Date
Agilent	E4448A	Spectrum Analyzer	2004-10-04

* **Statement of Traceability: BACL Corp.** attests that all calibrations have been performed in accordance to NVLAP requirements, traceable to the NIST.

Environmental Conditions

Temperature:	18° C
Relative Humidity:	43%
ATM Pressure:	1018 mbar

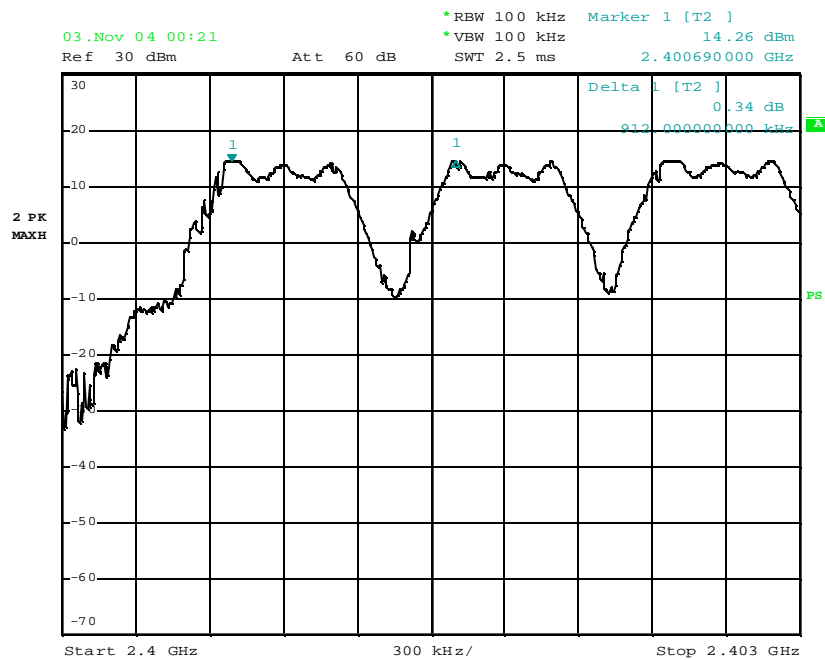
**The testing was performed by Snell Leong on 2004-11-03.*

Measurement Results

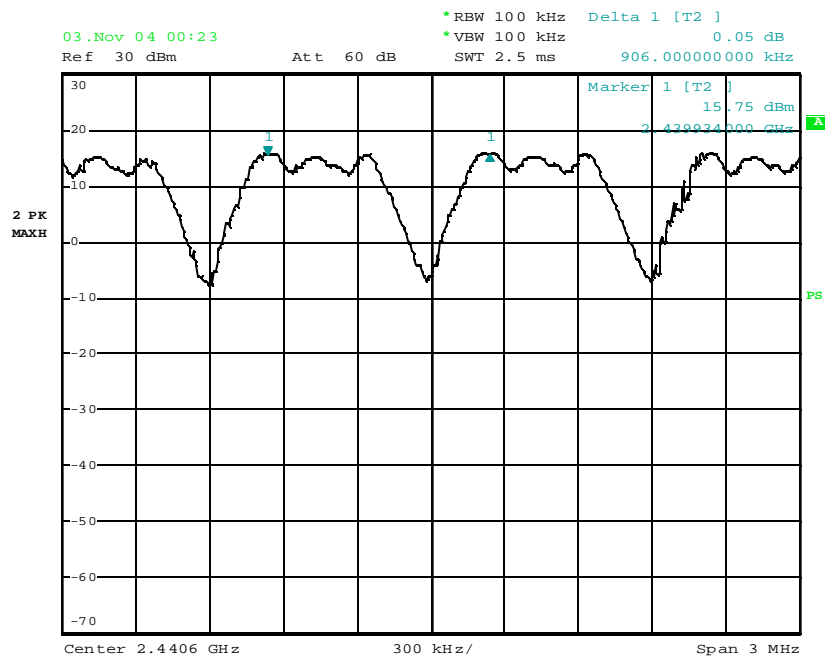
Channel	Measurement (KHz)	Result
Low	912	Compliant
Middle	906	Compliant
High	912	Compliant

Plots of Hopping Channel Separation

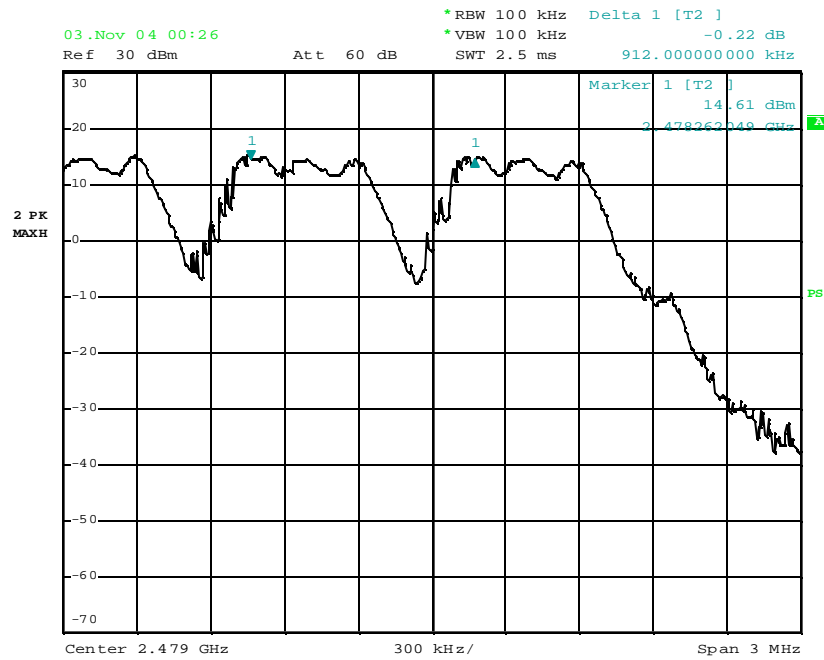
Please refer to the following plots.



Date: 3.NOV.2004 00:21:21



Date: 3.NOV.2004 00:23:59



Date: 3.NOV.2004 00:26:02

§15.247 (a) (1) - CHANNEL BANDWIDTH

Standard Applicable

According to §15.247(a)(1), frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25kHz or the 20 dB bandwidth of the hopping channel, whichever is greater.

Measurement Procedure

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT without connection to measurement instrument. Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range. Set a reference level on the measuring instrument equal to the highest peak value.
3. Measure the frequency difference of two frequencies that were attenuated 20 dB from the reference level. Record the frequency difference as the emission bandwidth.
4. Repeat above procedures until all frequencies measured were complete.

Test Equipment

Manufacturer	Model No.	Serial No.	Calibration Date
Agilent	E4448A	Spectrum Analyzer	2004-10-04

* **Statement of Traceability: BACL Corp.** attests that all calibrations have been performed per the NVLAP requirements, traceable to the NIST.

Environmental Conditions

Temperature:	18° C
Relative Humidity:	43%
ATM Pressure:	1018 mbar

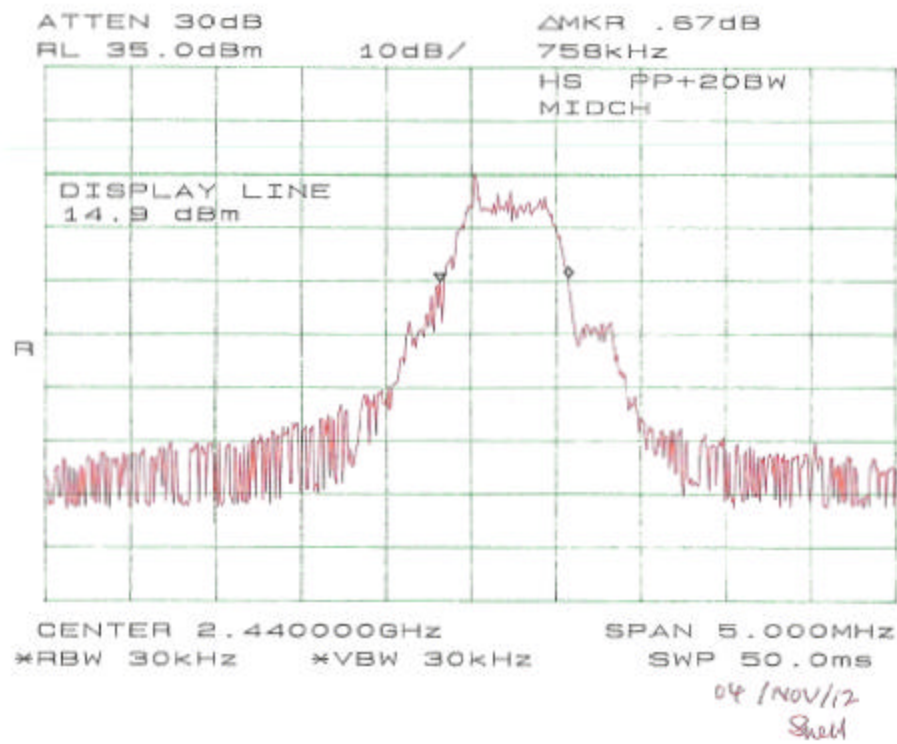
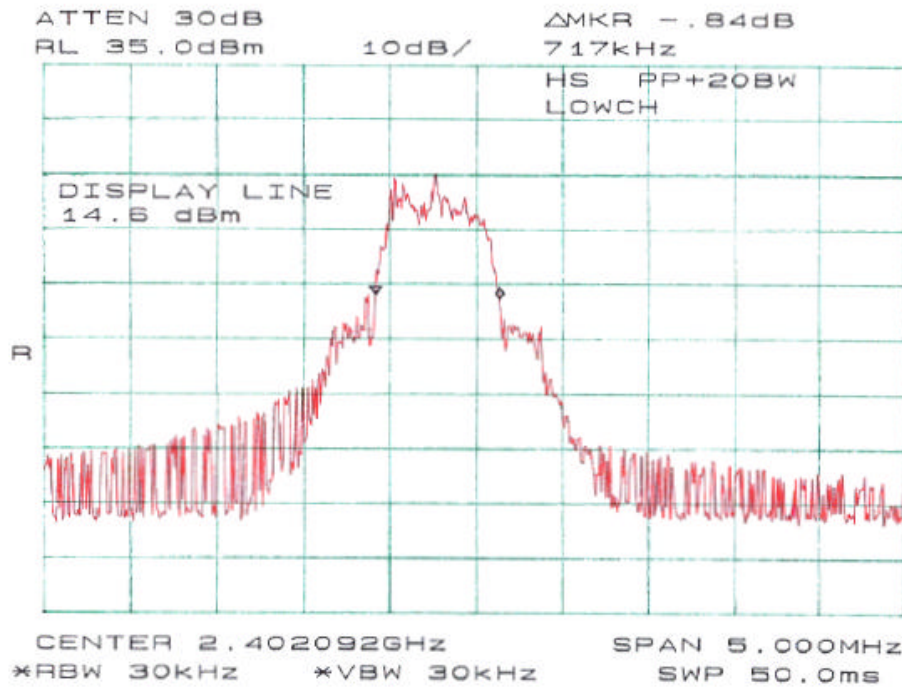
**The testing was performed by Snell Leong on 2004-11-02 and 2001-11-12.*

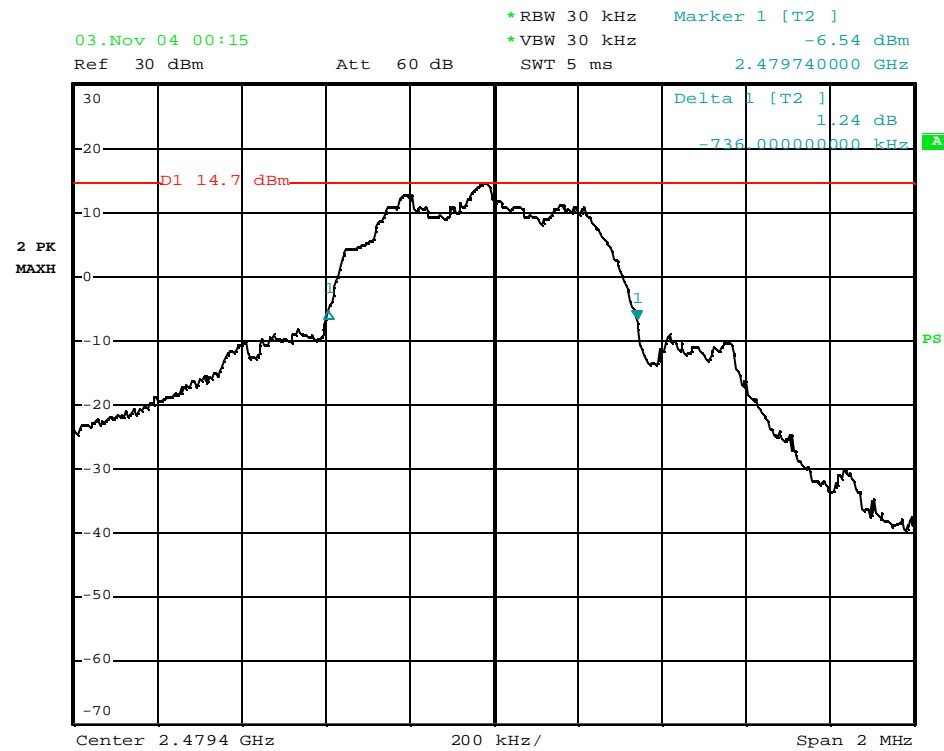
Measurement Result

Frequency	Measurement (kHz)	Standard	Result
Low	717	≤ 1MHz	Compliant
Middle	758	≤ 1MHz	Compliant
High	736	≤ 1MHz	Compliant

Plot of Channel Bandwidth

Please see the following plots





Date: 3.NOV.2004 00:15:43

§15.247 (a) (1) (iii) - NUMBER OF HOPPING FREQUENCY USED**Standard Applicable**

According to §15.247(a)(1)(iii), frequency hopping systems operating in the 2400-2483.5Mhz band shall use at least 75 hopping frequencies.

Measurement Procedure

1. Check the calibration of the measuring instrument (SA) using either an internal calibrator or a known signal from an external generator.
2. Position the EUT on the bench without connection to measurement instrument. Turn on the EUT and connect its antenna terminal to measurement instrument via a low loss cable. Then set it to any one measured frequency within its operating range, and make sure the instrument is operated in its linear range.
3. Set the SA on Max-Hold Mode, and then keep the EUT in hopping mode. Record all the signals from each channel until each one has been recorded.
4. Set the SA on View mode and then plot the result on SA screen.
5. Repeat above procedures until all frequencies measured were complete.

Test Equipment

Manufacturer	Model No.	Serial No.	Calibration Date
Agilent	E4448A	Spectrum Analyzer	2004-10-04

* **Statement of Traceability:** **BACL Corp.** attests that all calibrations have been performed in accordance to NVLAP requirements, traceable to the NIST.

Environmental Conditions

Temperature:	18° C
Relative Humidity:	43%
ATM Pressure:	1018 mbar

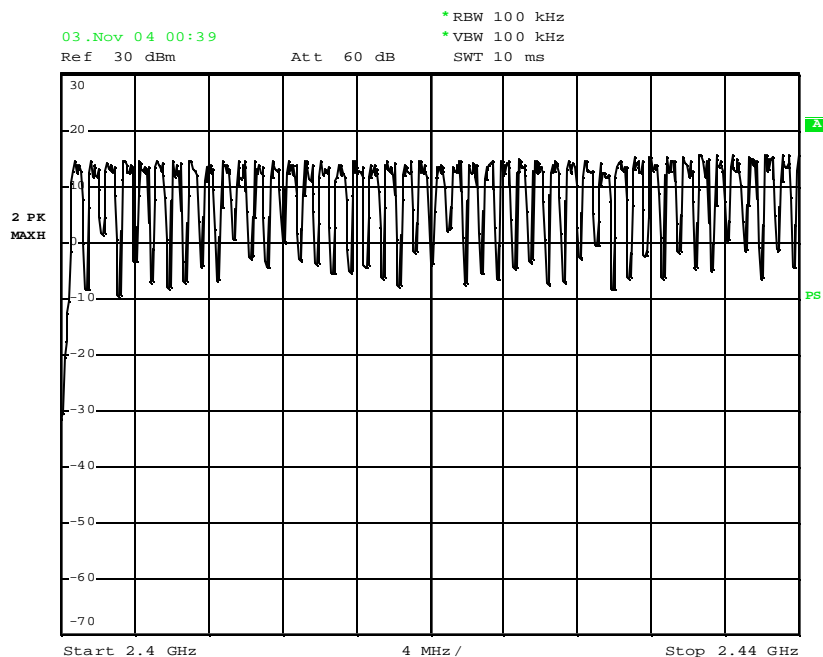
**The testing was performed by Snell Leong on 2004-11-03.*

Measurement Results

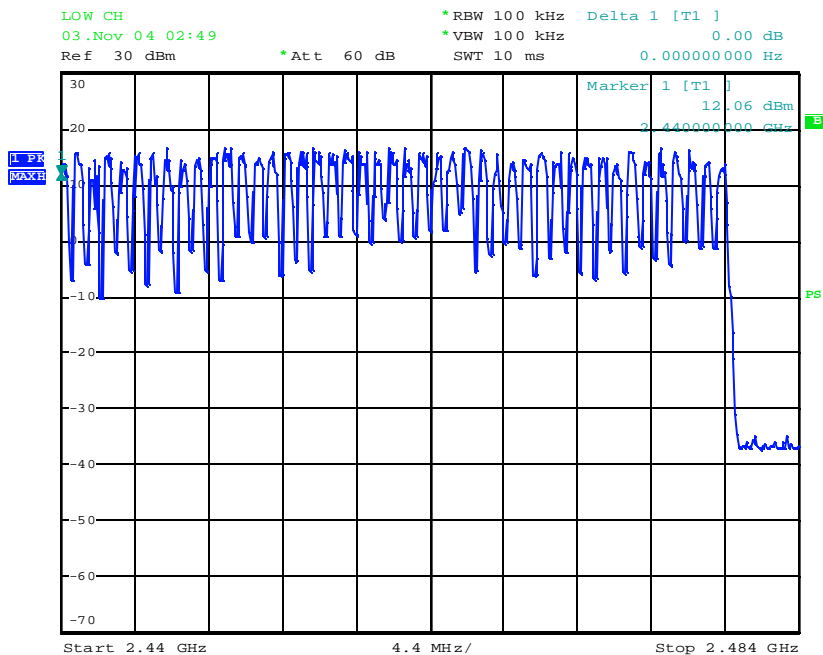
Measurement	Standard	Result
88	75	Compliant

Plots of Number of Hopping Frequency

Please refer to the attached plots.



Date: 3.NOV.2004 00:39:24



Date: 3.NOV.2004 02:49:09

§15.247 9 (a) (1) (iii) - DWELL TIME

Standard Applicable

According to §15.247 (a)(1)(iii), the average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.

Measurement Procedure

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT was set without connection to measurement instrument. Turn on the EUT and connect its antenna terminal to measurement instrument via a low loss cable. Then set it to any one measured frequency within its operating range, and make sure the instrument is operated in its linear range.
3. Adjust the center frequency of SA on any frequency be measured and set SA to zero span mode. And then, set RBW and VBW of spectrum analyzer to proper value.
4. Measure the time duration of one transmission on the measured frequency. And then plot the result with time difference of this time duration.
5. Repeat above procedures until all frequencies measured were complete.

Test Equipment

Manufacturer	Model No.	Serial No.	Calibration Date
Agilent	E4448A	Spectrum Analyzer	2004-10-04

* **Statement of Traceability:** BACL Corp. attests that all calibrations have been performed per the NVLAP requirements, traceable to the NIST.

Environmental Conditions

Temperature:	18° C
Relative Humidity:	43%
ATM Pressure:	1018 mbar

*The testing was performed by Snell Leong on 2004-11-03.

Measurement Results

Channel	Frequency MHz	Pulse Wide uSec	Occupied time per .4* 88 sec	Dwell Time Sec	Limit Sec
Low	2400.89	1002	48	0.048096	0.4
Mid	2440.16	1040	44	0.04576	0.4
High	2479.4	1045	43	0.044935	0.4

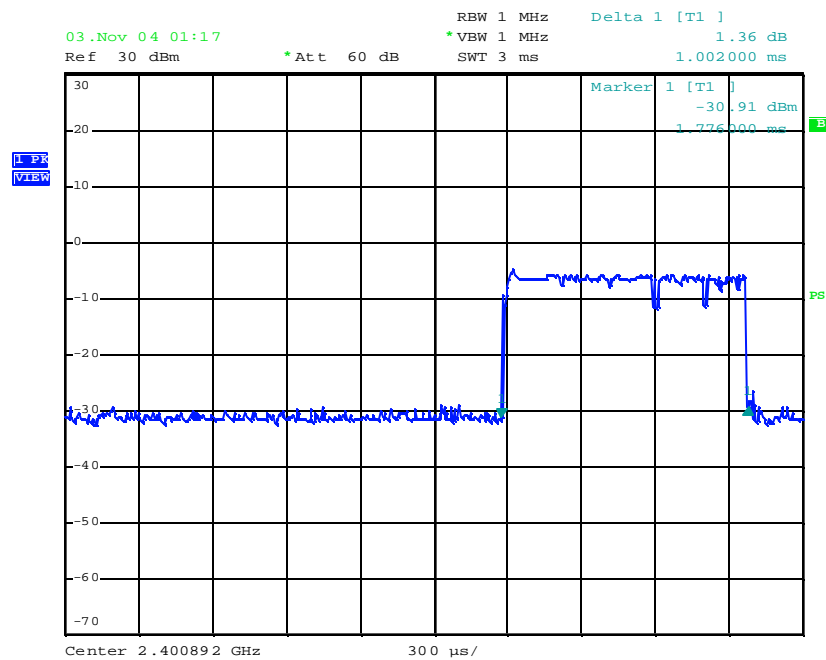
Low Channel Dwell Time: $1002 \times 48 / 1000 = 48.096$ Msec

Mid Channel Dwell Time: $1040 \times 44 / 1000 = 45.76$ Msec

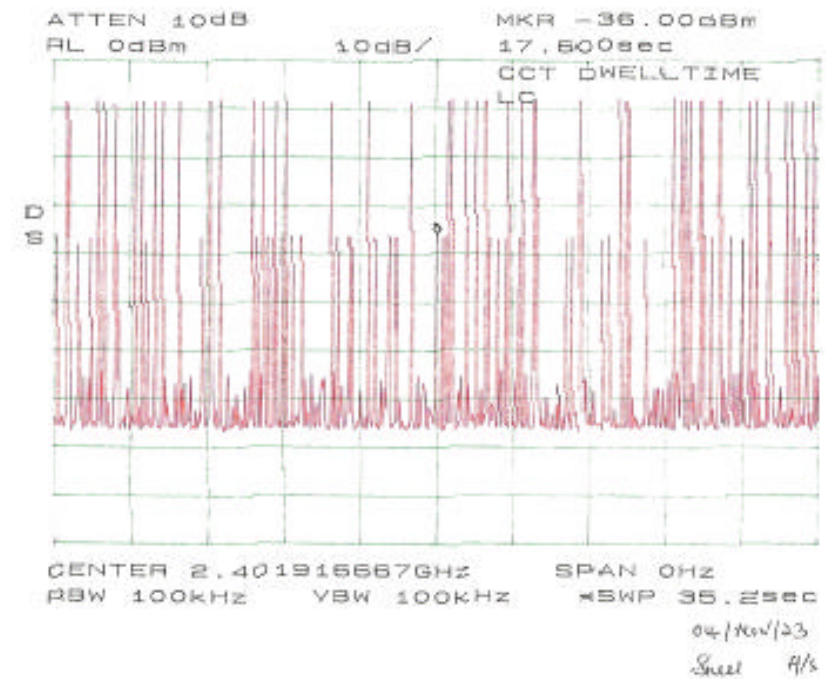
High Channel Dwell Time: $1045 \times 43 / 1000 = 44.935$ Msec

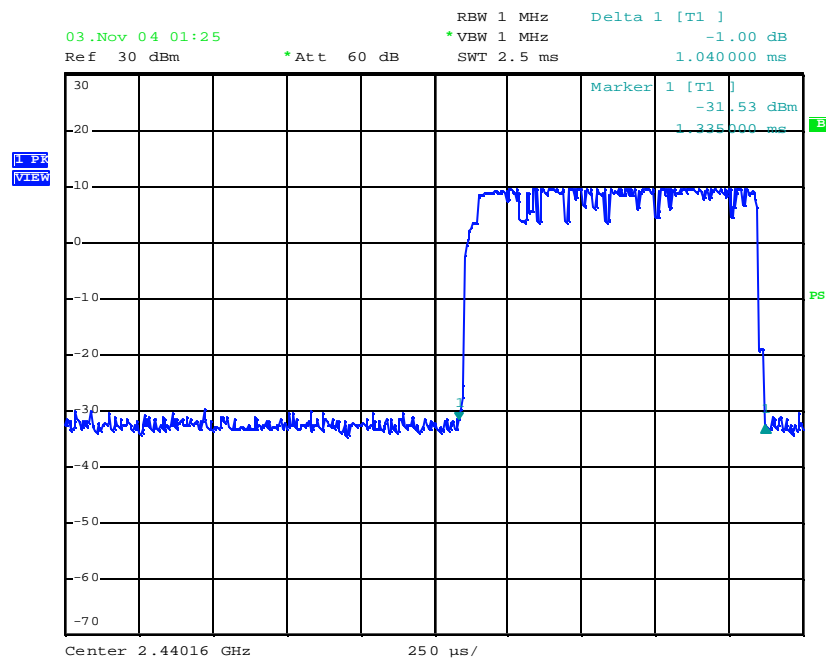
Plots of Dwell Time

Please refer the following plots.

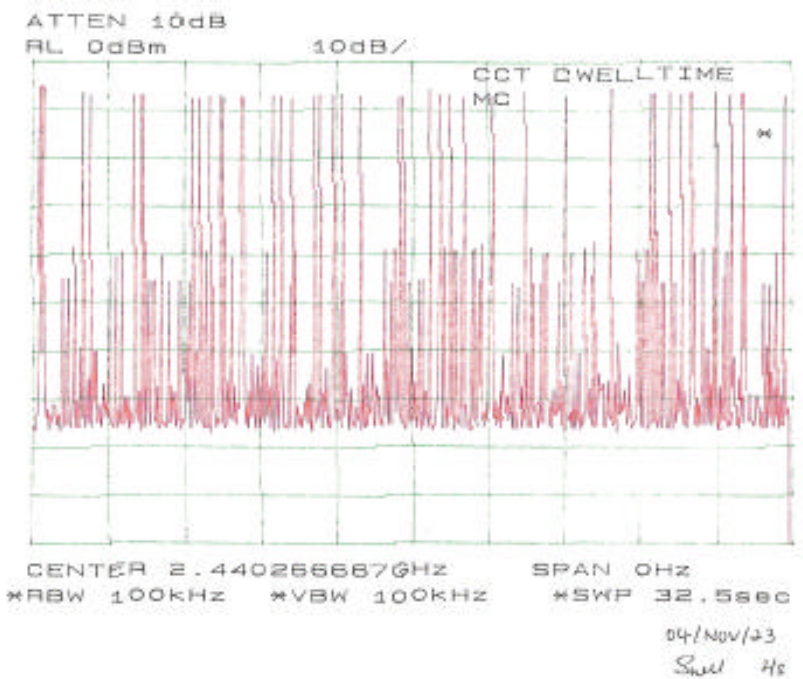


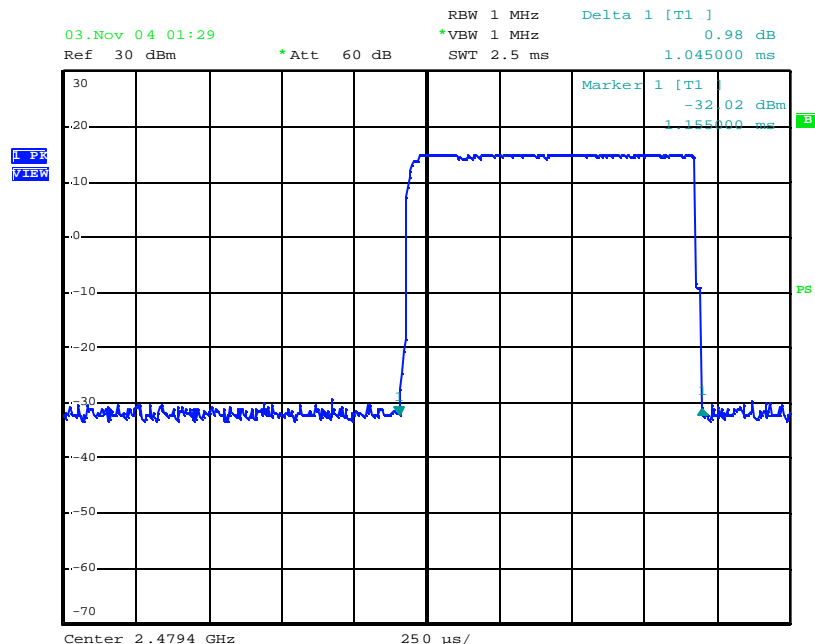
Date: 3.NOV.2004 01:17:31



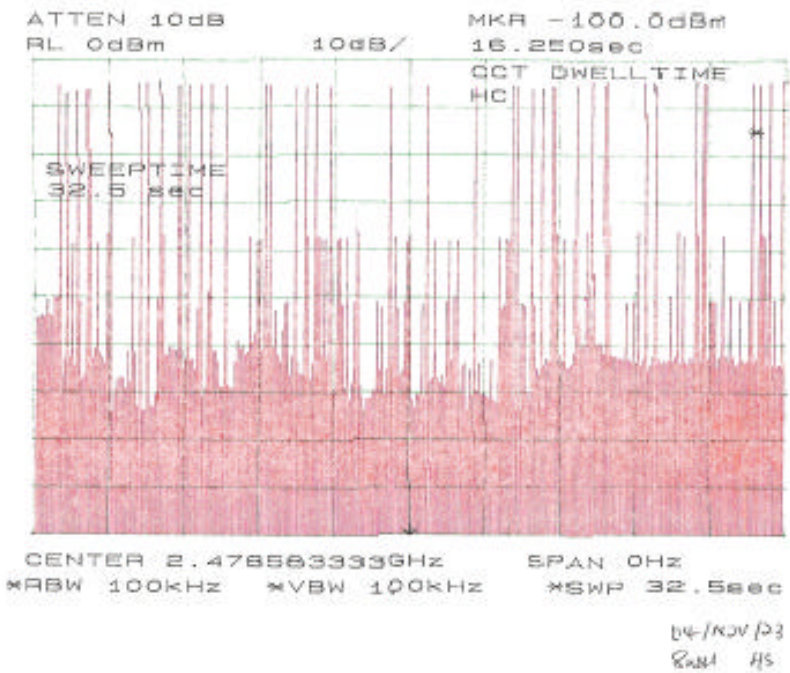


Date: 3.NOV.2004 01:25:27





Date: 3.NOV.2004 01:29:07



§15.247 (b) (1) - MAXIMUM PEAK OUTPUT POWER

Standard Applicable

According to §15.247(b) (1), for frequency hopping systems in the 2400-2483.5MHz band employing at least 75 hopping channels, and all direct sequence systems, the maximum peak output power of the transmitter shall not exceed 1 Watt.

Measurement Procedure

1. Place the EUT on the turntable and set it in transmitting mode.
2. Remove the antenna from the EUT and then connect a low loss RF cable from the antenna port to the spectrum analyzer.

Test Equipment

Manufacturer	Model No.	Serial No.	Calibration Date
Agilent	E4448A	Spectrum Analyzer	2004-10-04

* **Statement of Traceability: BACL Corp.** attests that all calibrations have been performed per the NVLAP requirements, traceable to the NIST.

Environmental Conditions

Temperature:	18° C
Relative Humidity:	43%
ATM Pressure:	1018 mbar

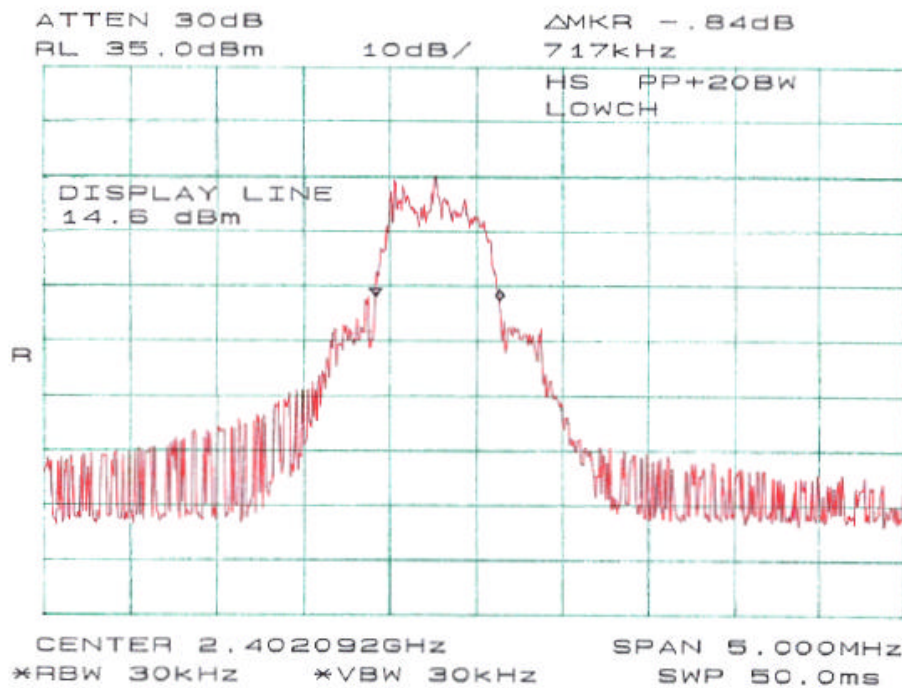
**The testing was performed by Snell Leong on 2004-11-02.*

Measurement Result

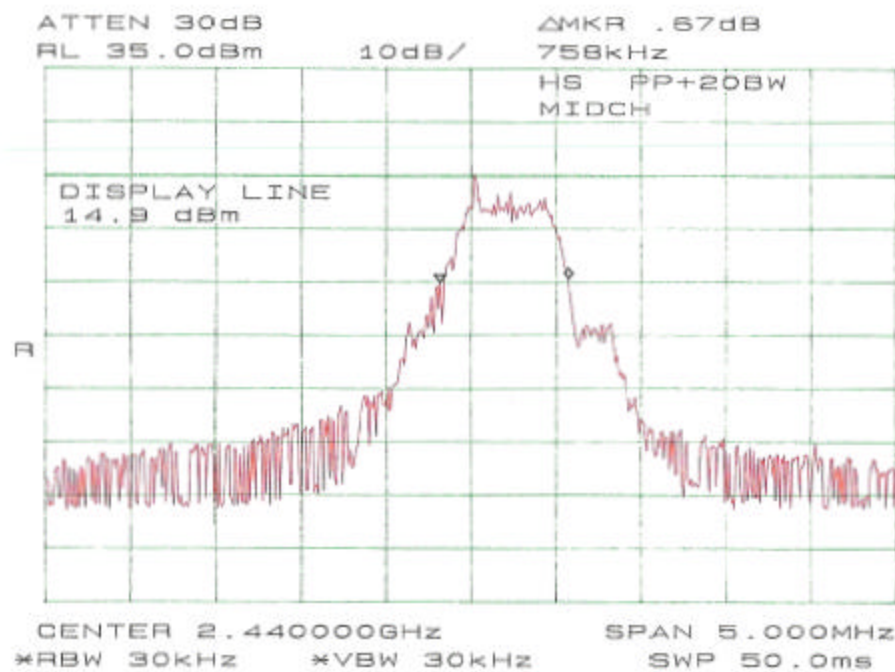
Channel	Frequency (MHz)	Corrected Output Power (dBm) (W)		Standard	Result
Low	2400.89	14.6	0.0288	≤ 1W	Compliant
Middle	2440.16	14.9	0.0309	≤ 1W	Compliant
High	2479.40	14.7	0.0295	≤ 1W	Compliant

Plots of Maximum Peak Output Power

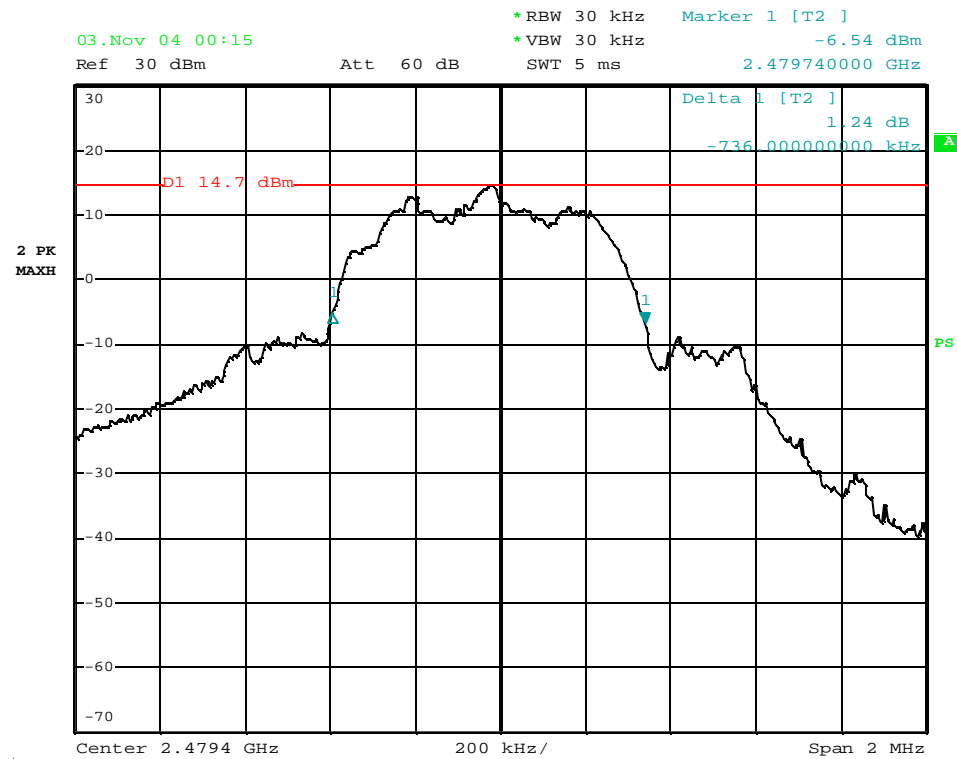
Please see the following plots



04/NOV/12
Shed



04/NOV/12
Shed



Date: 3.NOV.2004 00:15:43

§15.247 (c) - 100 KHZ BANDWIDTH OF BAND EDGES

Standard Applicable

According to §15.247(c), in any 100 kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in §15.209(a) is not required.

Measurement Procedure

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT without connection to measurement instrument. Turn on the EUT and connect its antenna terminal to measurement instrument via a low loss cable. Then set it to any one measured frequency within its operating range, and make sure the instrument is operated in its linear range.
3. Set both RBW and VBW of spectrum analyzer to 100 kHz with a convenient frequency span including 100kHz bandwidth from band edge.
4. Measure the highest amplitude appearing on spectral display and set it as a reference level. Plot the graph with marking the highest point and edge frequency.
5. Repeat above procedures until all measured frequencies were complete.

Test Equipment

Manufacturer	Model No.	Serial No.	Calibration Date
Agilent	E4448A	Spectrum Analyzer	2004-10-04

* **Statement of Traceability: BACL Corp.** certifies that all calibrations have been performed in accordance to NVLAP requirements, traceable to the NIST.

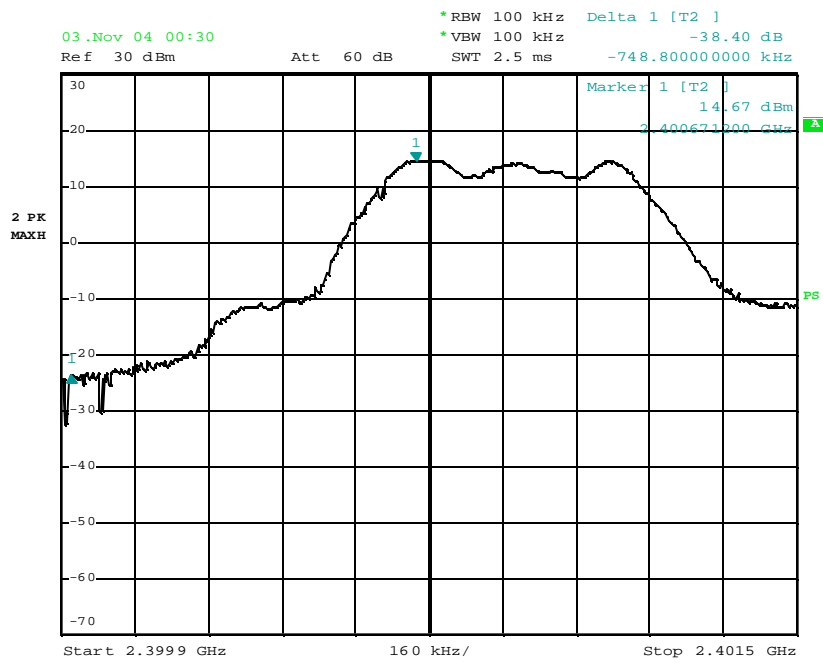
Environmental Conditions

Temperature:	18° C
Relative Humidity:	43%
ATM Pressure:	1018 mbar

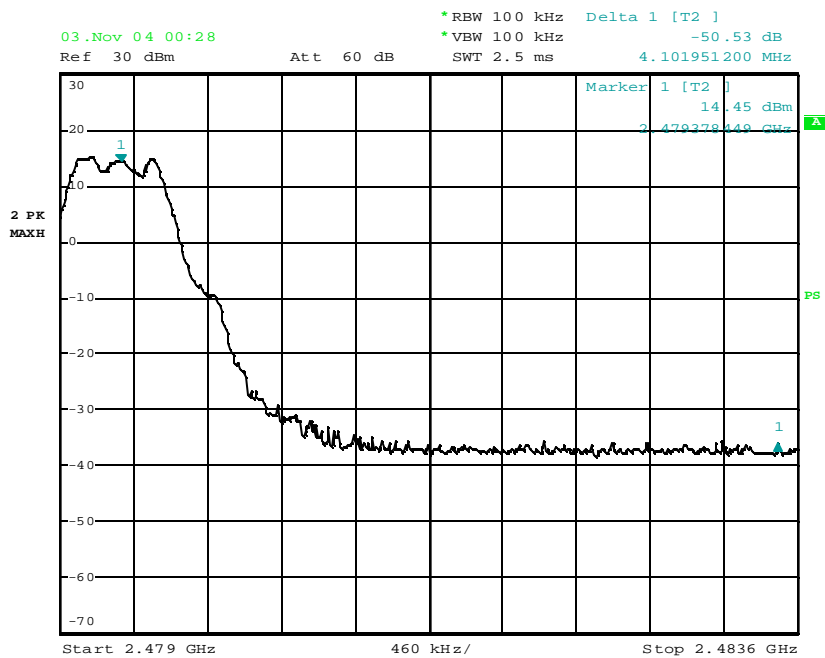
**The testing was performed by Snell Leong on 2004-11-03.*

Plots of 100kHz Bandwidth of Band Edge

Please refer the following plots.



Date: 3.NOV.2004 00:30:56



Date: 3.NOV.2004 00:28:50

SPURIOUS EMISSION AT ANTENNA PORT

Standard Applicable

According to §15.209 (f) and §15.33(a), in some cases the emissions from an intentional radiator must be measured to beyond the tenth harmonic of the highest fundamental frequency designed to be emitted by the intentional radiator because of the incorporation of a digital device. If measurements above the tenth harmonic are so required, the radiated emissions above the tenth harmonic shall comply with the general radiated emission limits applicable to the incorporated digital device, as shown in §15.109 and as based on the frequency of the emission being measured, or, except for emissions contained in the restricted frequency bands shown in §15.205, the limit on spurious emissions specified for the intentional radiator, whichever is the higher limit.

Measurement Procedure

1. Check the calibration of the measuring instrument (SA) using either an internal calibrator or a known signal from an external generator.
2. Position the EUT on a bench without connection to measurement instrument. Turn on the EUT and connect its antenna terminal to measurement instrument via a low loss cable. Then set it to any one measured frequency within its operating range, and make sure the instrument is operated in its linear range.
3. Set the SA on Max-Hold Mode, and then keep the EUT in transmitting mode. Record all the signals from each channel until each one has been recorded.
4. Set the SA on View mode and then plot the result on SA screen.
5. Repeat above procedures until all frequencies measured were complete.

Test Equipment

Manufacturer	Model No.	Serial No.	Calibration Date
Agilent	8564E	Spectrum Analyzer	2004-08-01

* **Statement of Traceability: BACL Corp.** attests that all calibrations have been performed per the NVLAP requirements, traceable to the NIST.

Environmental Conditions

Temperature:	18° C
Relative Humidity:	43%
ATM Pressure:	1018 mbar

**The testing was performed by Snell Leong on 2004-10-27.*

Measurement Results

Please refer to the following plots.

